

Search Notes

Application/Control No.

10/537,079

Examiner

J. Pasterczyk

Applicant(s)/Patent under
Reexamination

DIEGO ET AL.

Art Unit

1755

SEARCHED

Class	Subclass	Date	Examiner
502	118 125-127	6/06	JP
	137		
	158		
	169		
	172		
526	124.9		
	125.1		
	125.3		
	125.4		
	125.6		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR